



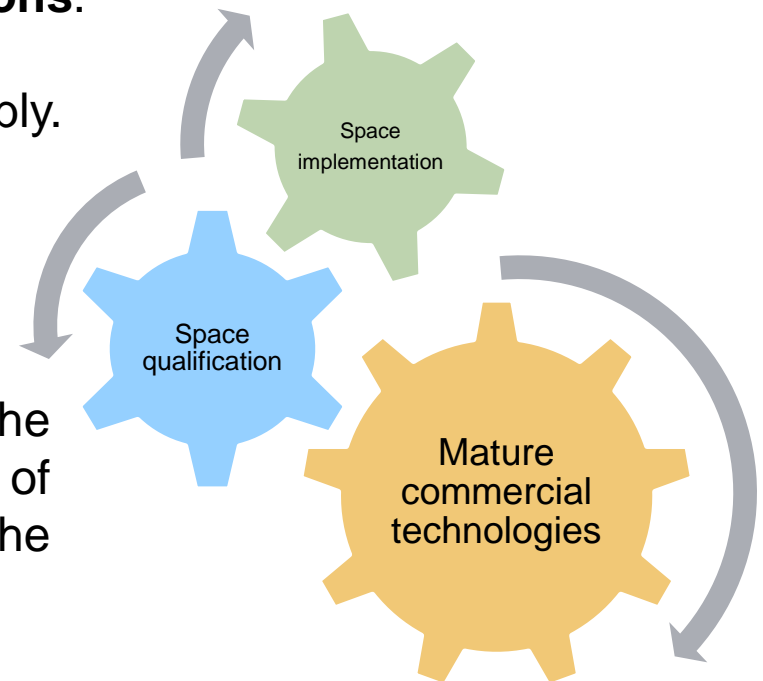
# **EVALUATION OF PRESS-FIT CONNECTOR FOR SPACE-FLIGHT APPLICATIONS, FEEDBACK AND DESIGN IMPROVEMENTS**



# INTRODUCTION



- ❑ Trends show an increasing demand for the **incorporation of new fabrication concepts and components** into the space industry. This requires for **fast and reliable evaluation processes** adapted to the specific system design and the characteristics.
- ❑ Press-fit technology is already consolidated in different industrial sectors and currently **is emerging for space applications**.
  - Solder-less alternative for PCB assembly.
  - Cost and time effective.
- ❑ This communication reports on the qualification process to assess the reliability of selected press-fit connector for the implementation in space applications.



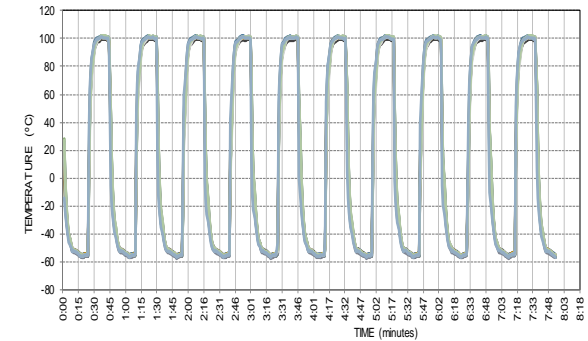
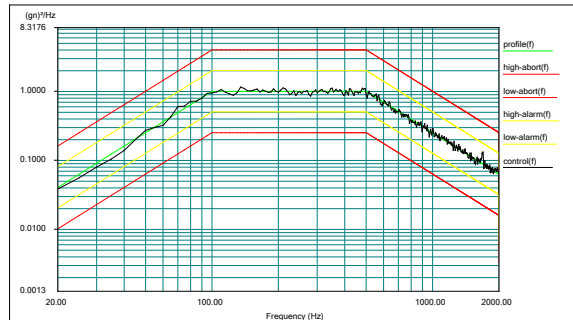


Thorough and accurate tests are conducted to determine the suitability for space applications

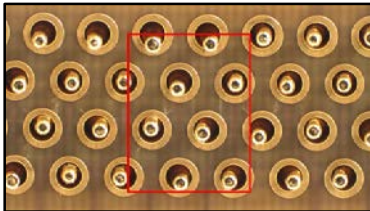


Environmental test

Vibration  
and temperature cycling

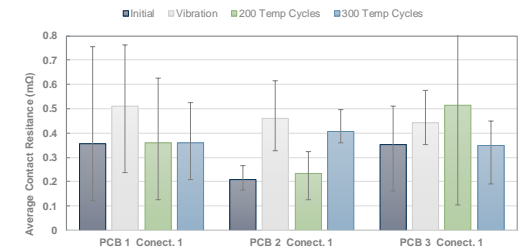


Control visual  
inspections



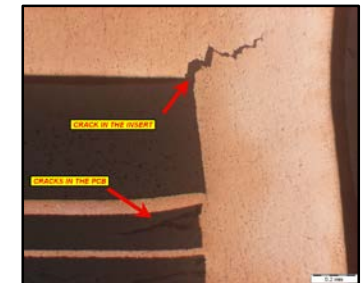
**Standard and high density  
connectors comply with the  
space regulation**

Control electrical  
measurements



Microsectioning

Microinspection





# OUTLINE



1. Compliant-Press-Fit concept

2. Test vehicles and test flow

3. Vibration test

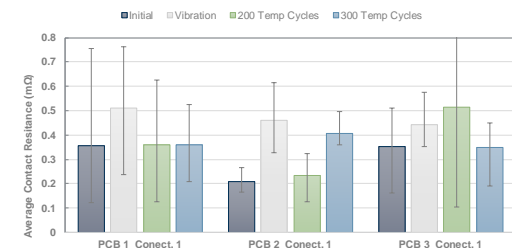
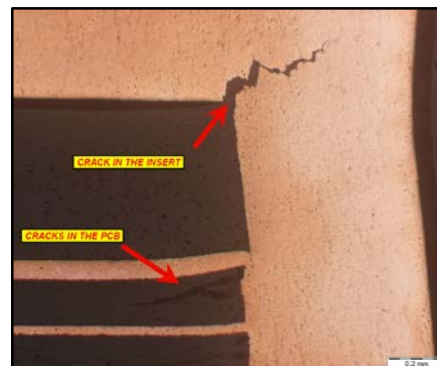
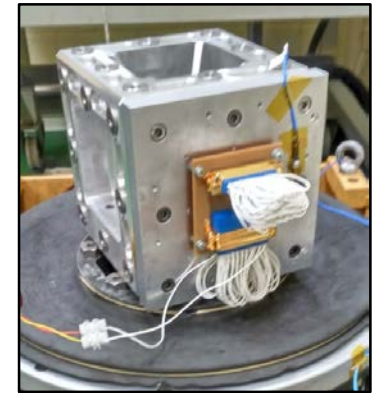
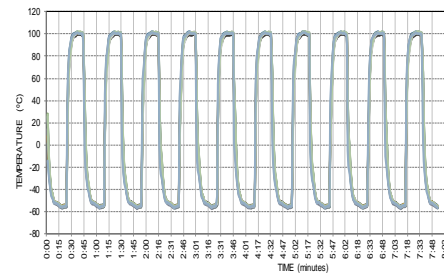
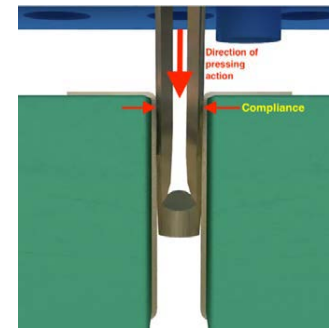
4. Temperature cycling

5. Visual inspection and electrical verification control test

6. Micro section inspection

7. 2<sup>nd</sup> Generation

8. Summary

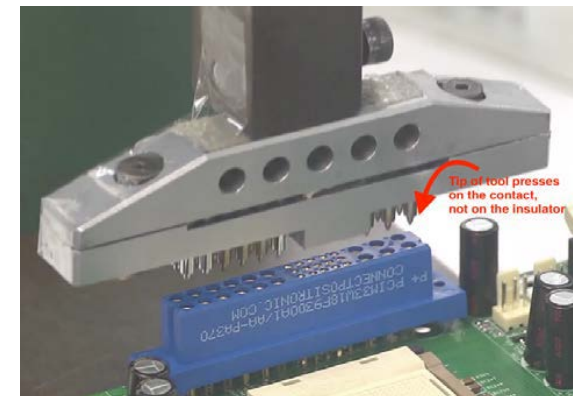
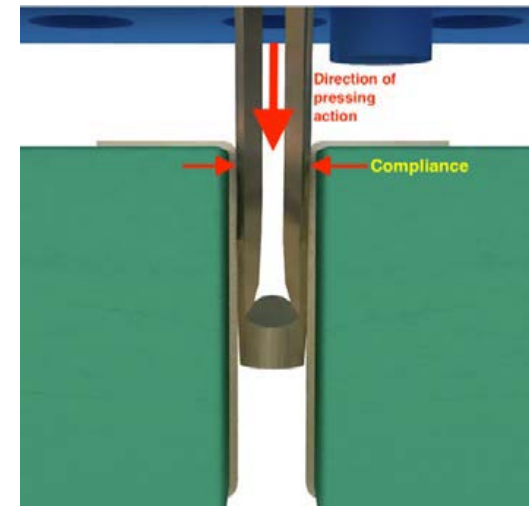




# COMPLIANT-PRESS-FIT CONCEPT



- ❖ Deformable tail is inserted into a plate through hole (PTH).
- ❖ PTH slightly narrower than the insertion pin.
- ❖ Eye-of-the-needle design: The tail is adapted to the PTH at the same time that the spring-force ensures permanent low-resistivity electrical contact.





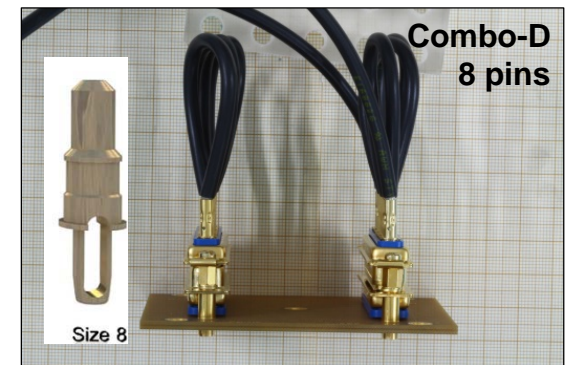
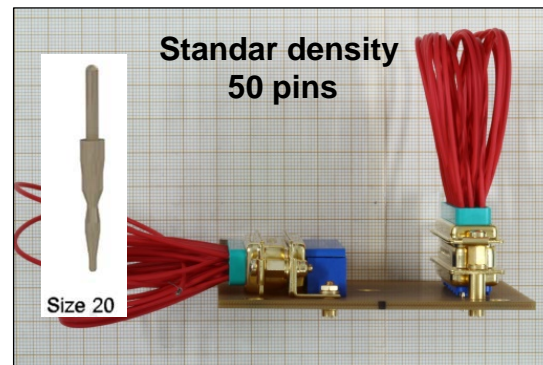
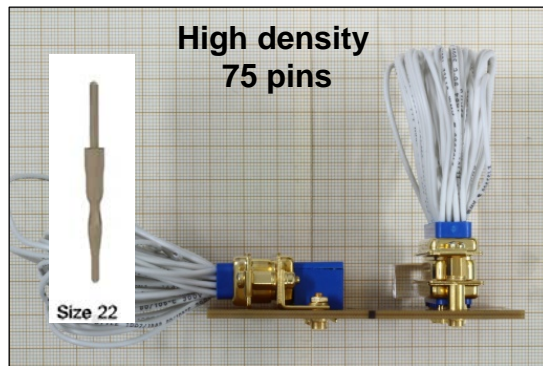
# TEST VEHICLES

3 types of **press fit** connectors conceived for **different applications**:

- ✓ Signal communication.
- ✓ Low power supply.
- ✓ High power supply.

## General PCB characteristics

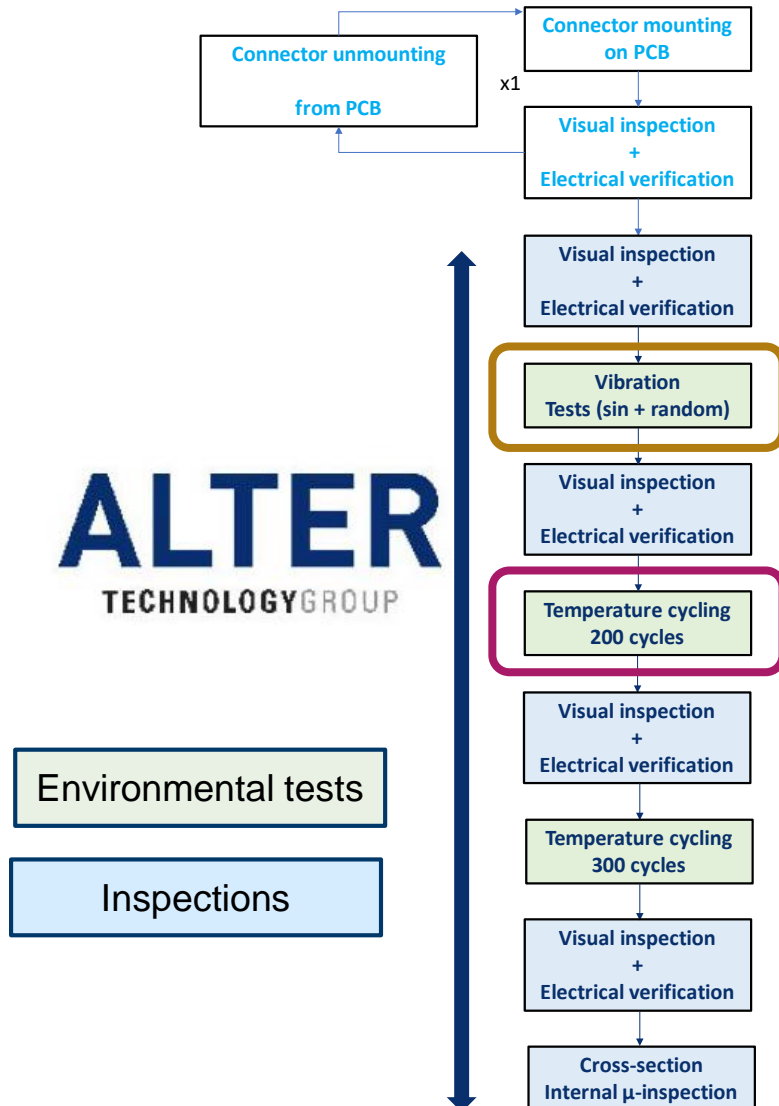
- 4 Cu layers of 2.4 mm of thickness
- Electroless Nickel Immersion Gold (ENIG)
- PTHs gold coating of 5  $\mu$ m of thickness



Denomination	Pin size	Number of pins	Intended application	Quantuty
High density	22	75	Singal comunication	3 PCBs with 2 connectors
Standard density	20	50	Low power supply	3 PCBs with 2 connectors
Combo-D	8	5	High power supply	3 PCBs with 2 connectors



# TEST FLOW



Qualification program adapted from ECSS-Q-ST-70-38C for surface mounting technology but **including harder requirements**

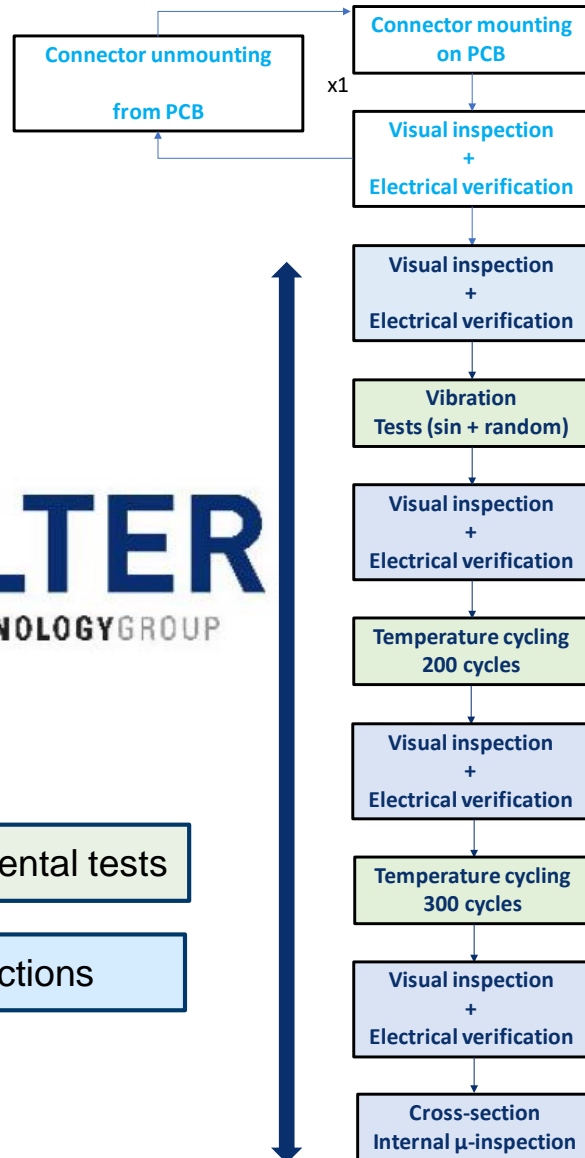
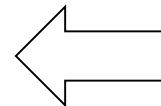
Test / inspection	Specification
Visual inspection	ESCC 20500
Electrical characterization	DENG-008-1 Rev. B § 7 (customer procedure)
Vibration	ECSS Q ST 70 08C § 13 (sine + random) <b>Additional provision μ-cuts ≥ 1 μs are not allowed</b>
Temperature Cycling	DENG-008-1 Rev. B Par. 14 <b>-55 °C to +100 °C abrupt thermal shock</b>
Cross-section μ-inspection	DENG-008-1 Rev. B





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Vibration



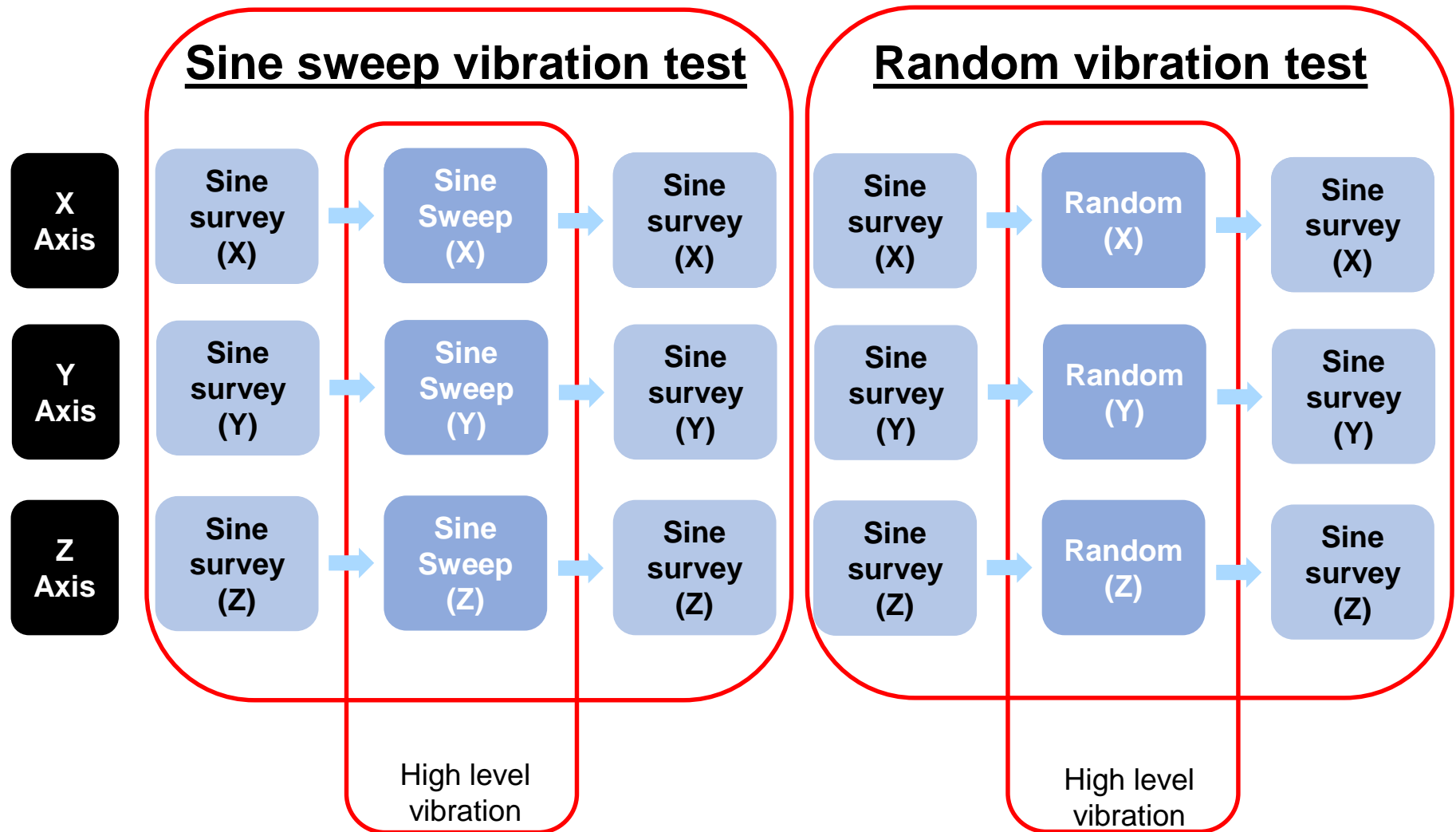
**ALTER**  
TECHNOLOGY GROUP

Environmental tests

Inspections



# VIBRATION TEST: TEST SEQUENCE

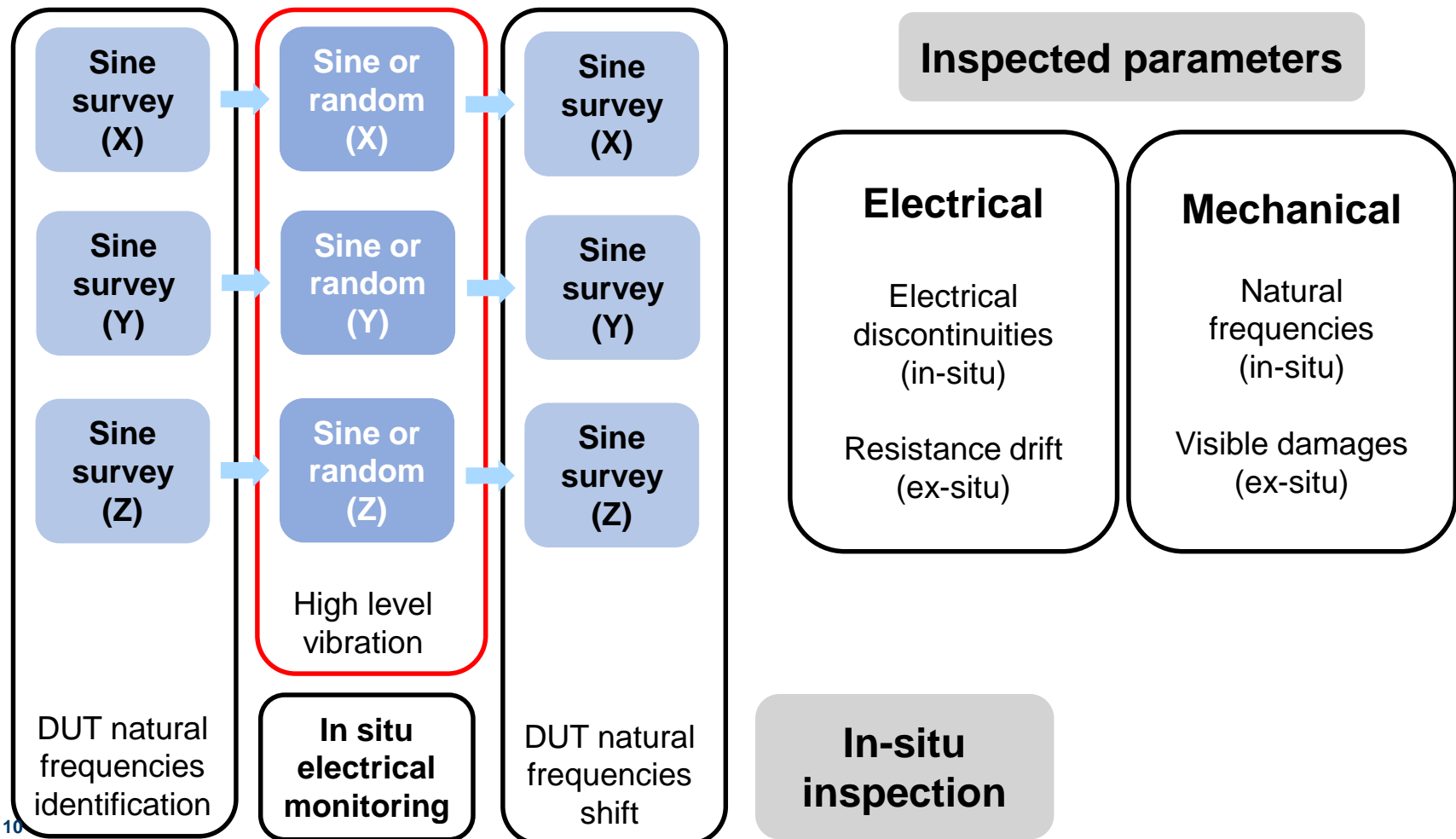




# VIBRATION TEST: INSPECTED PARAMETERS



## Sine sweep and random vibration tests

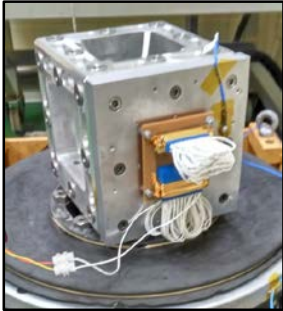




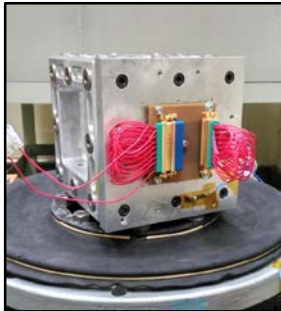
# VIBRATION TEST: SET-UP



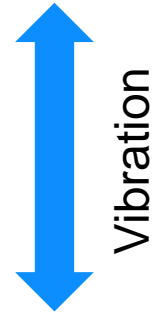
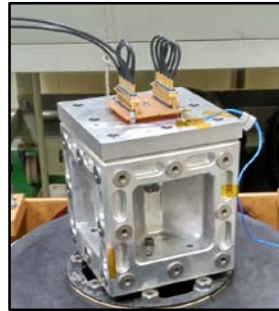
**X-axis  
vibration**



**Y-axis  
vibration**

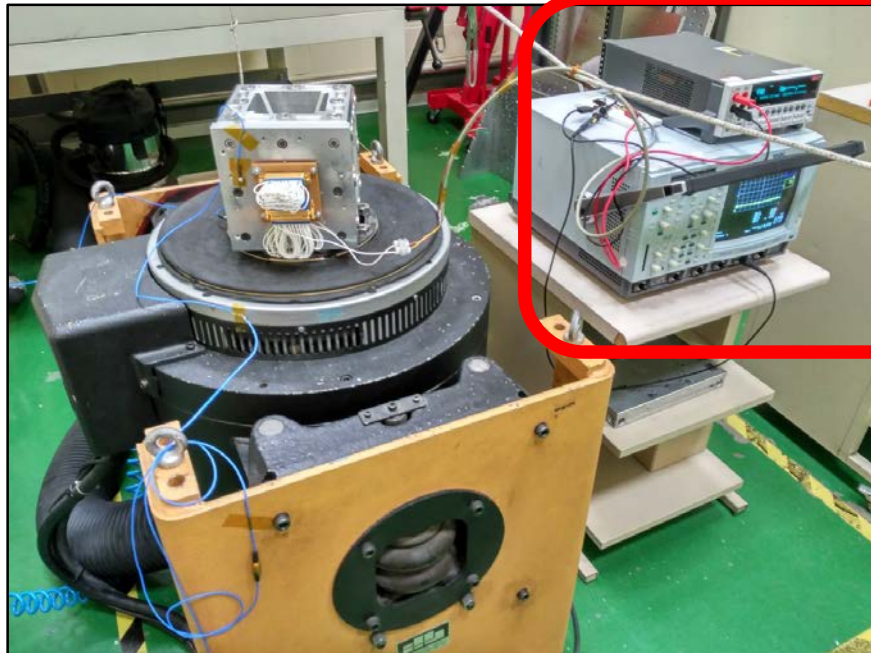
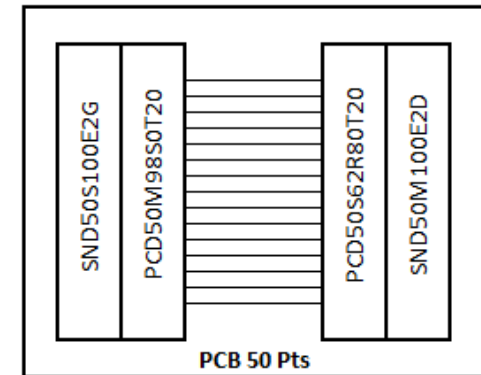


**Z-axis  
vibration**

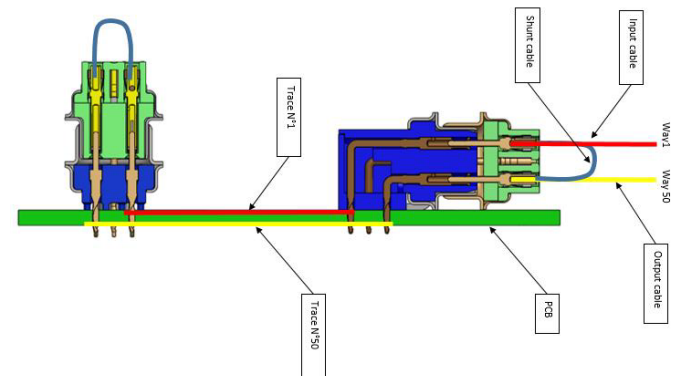


Vibration

Daysi chain electrical  
monitoring



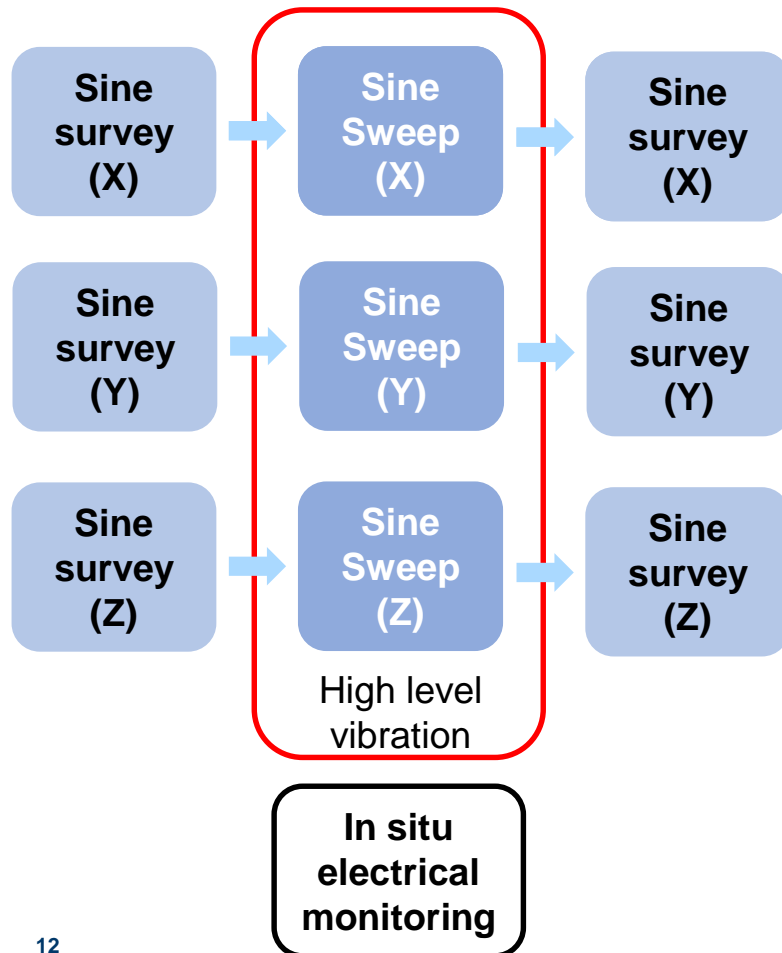
Electrical  
monitoring



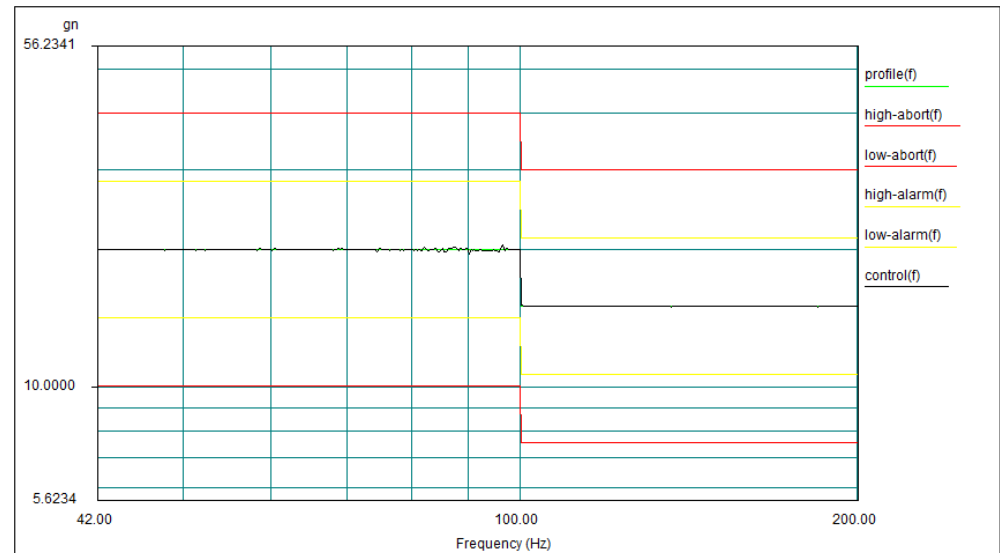


# VIBRATION TEST: SINE SWEEP

**No discontinuities longer than 1  $\mu$ s were observed**



Vibration level follows the required profile neither resonances nor other deviations were observed



## Sine Sweep conditions

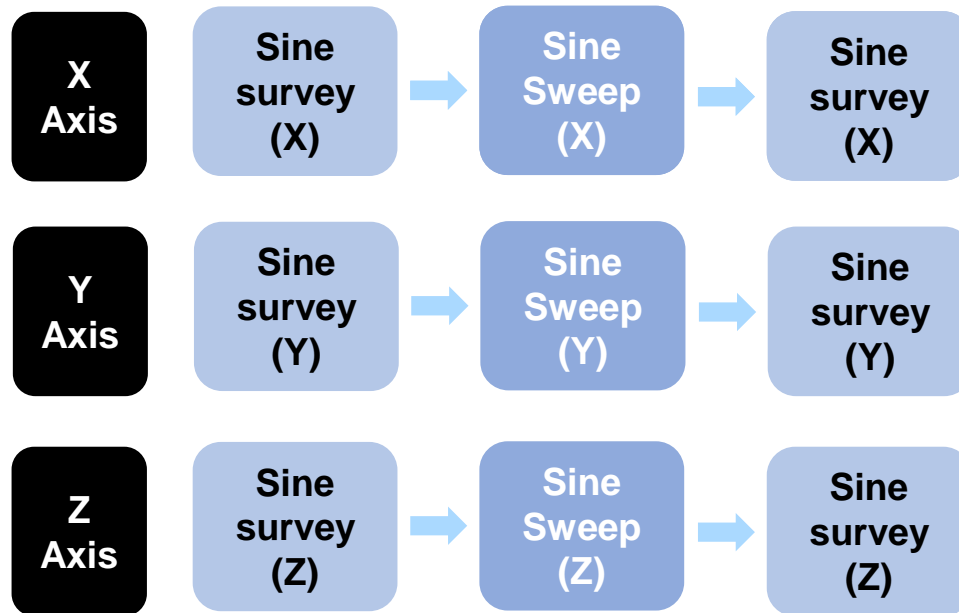
Range	Amplitude (0 to peak)	Sweep rate
25 to 100 Hz	20 g	1 oct/min
100 to 200 Hz	15 g	1 oct/min



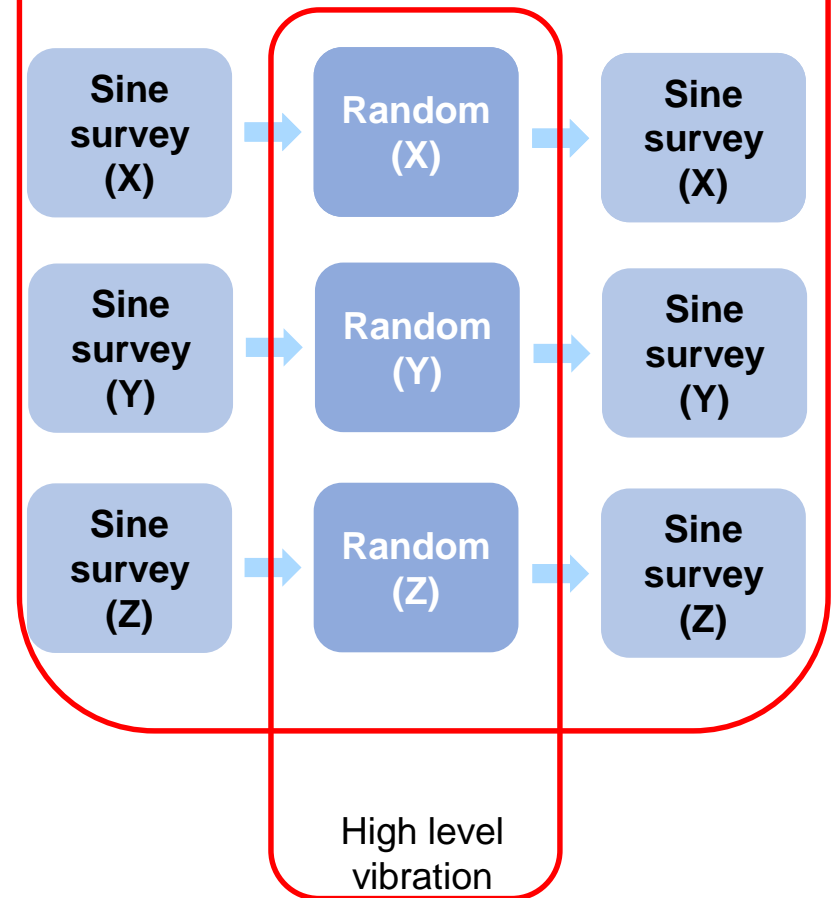
# VIBRATION TEST: RANDOM



## Sine sweep vibration test



## Random vibration test



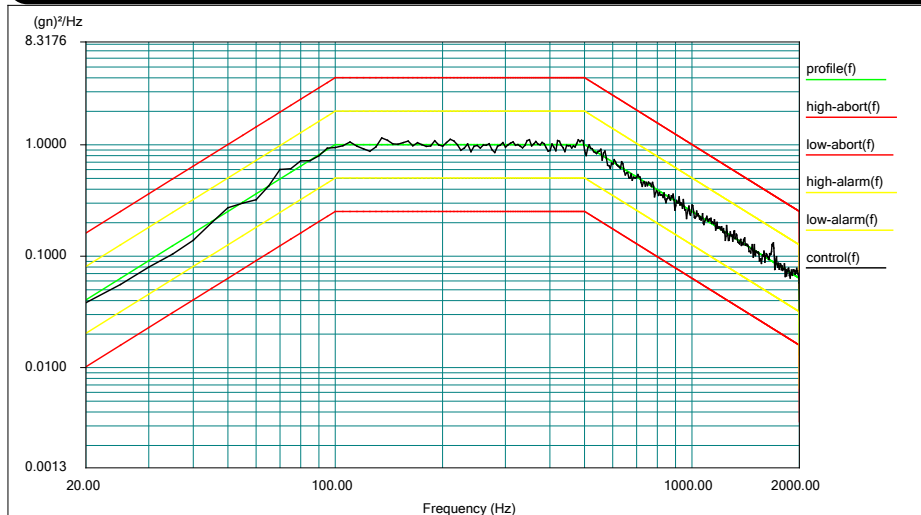


# VIBRATION TEST: RANDOM



**No discontinuities longer than 1  $\mu$ s were observed**

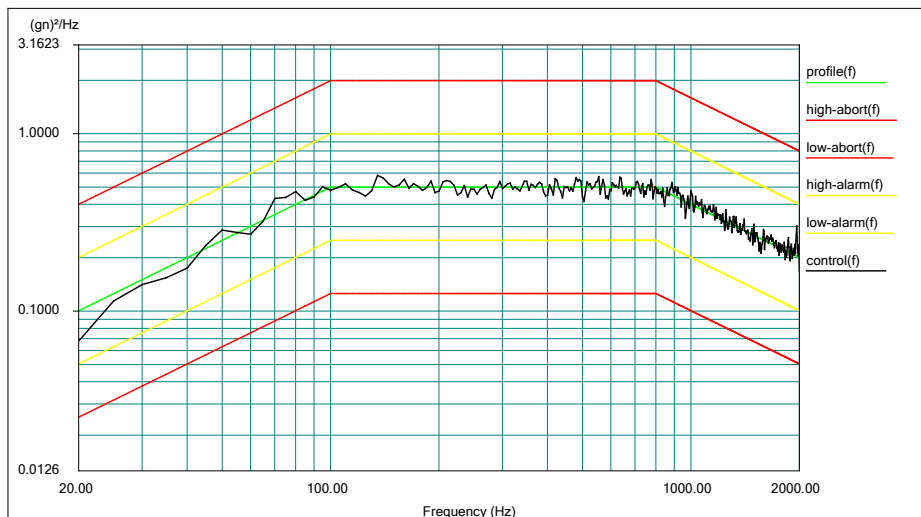
Vibration level confined within the required range.  
Neither resonances nor other deviations were observed



## Perpendicular to PCB

Range (Hz)	PSD level
20 to 100	+6 dB/oct (ramp)
100 to 500	1 g <sup>2</sup> /Hz (plateau)
500 to 2000	-6 dB/oct (ramp)

**Global RMS 28.5**



## Parallel to PCB

Range (Hz)	PSD level
20 to 100	+3 dB/oct (ramp)
100 to 800	0.5 g <sup>2</sup> /Hz (plateau)
800 to 2000	-3 dB/oct (ramp)

**Global RMS 27.1**

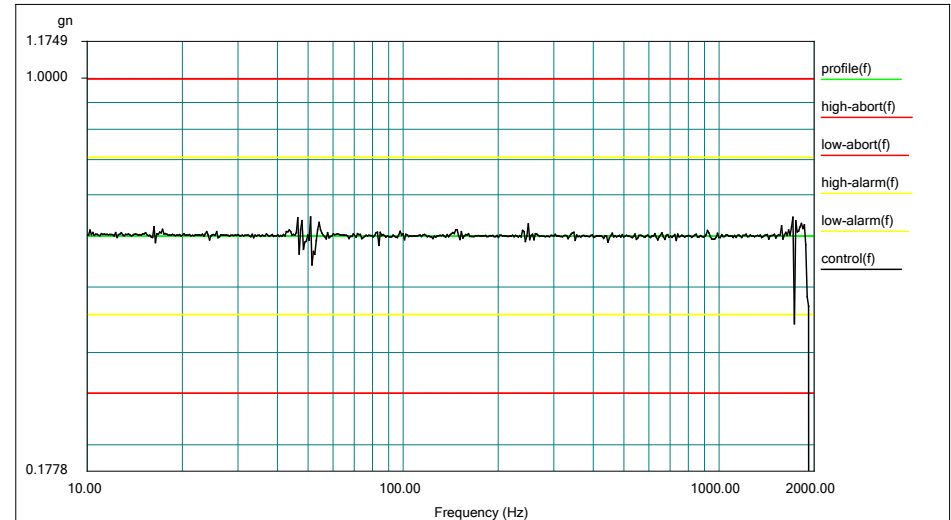
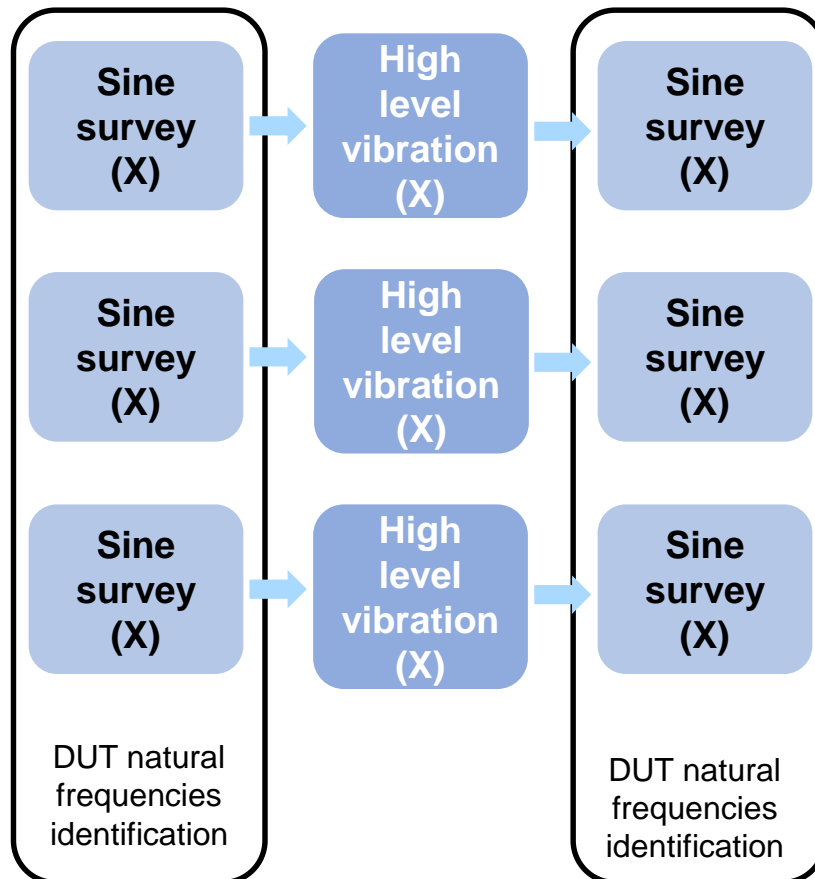


# VIBRATION TEST: NATURAL FREQUENCIES



## Sine survey

Natural frequencies analysis



### Test conditions

Amplitude	0.5 g (0 to peak)
Frequency	10 to 2000 Hz
Sweep rate	2 oct/min
Direction	X, Y & Z



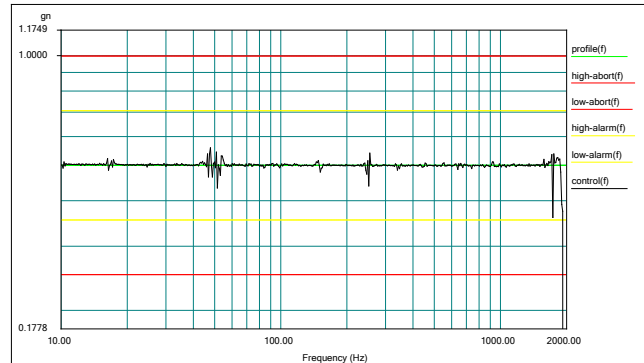
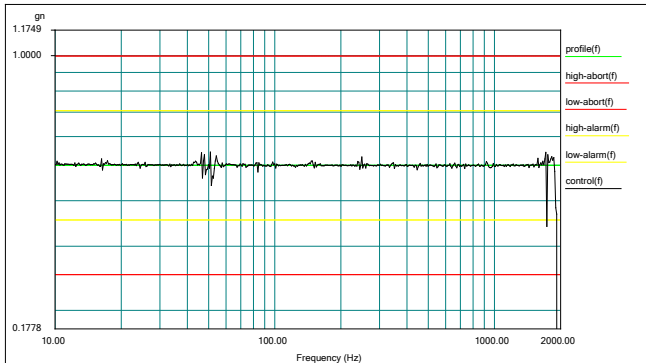
# VIBRATION TEST: NATURAL FREQUENCIES



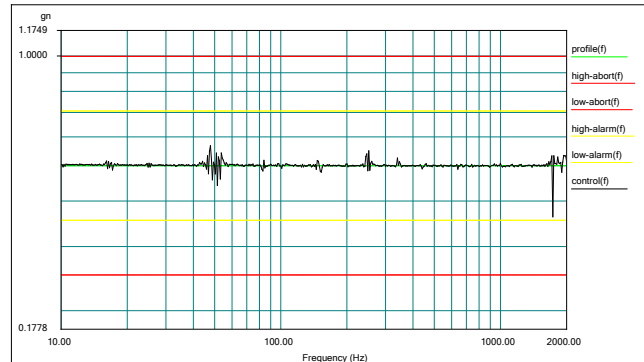
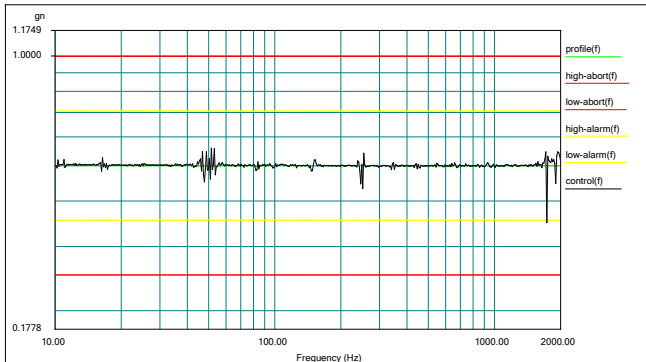
Initial

After high level vibration

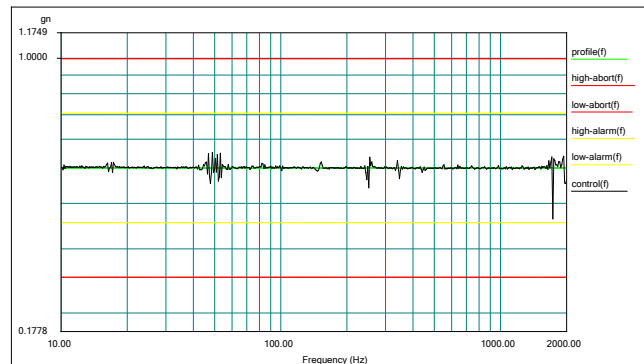
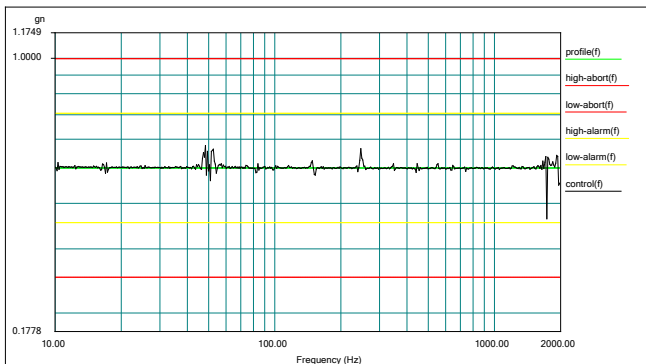
X-Axis



Y-Axis



Z-Axis



**After high level vibration**

(sine sweep and random)

The DUT preserves its mechanical impedance.

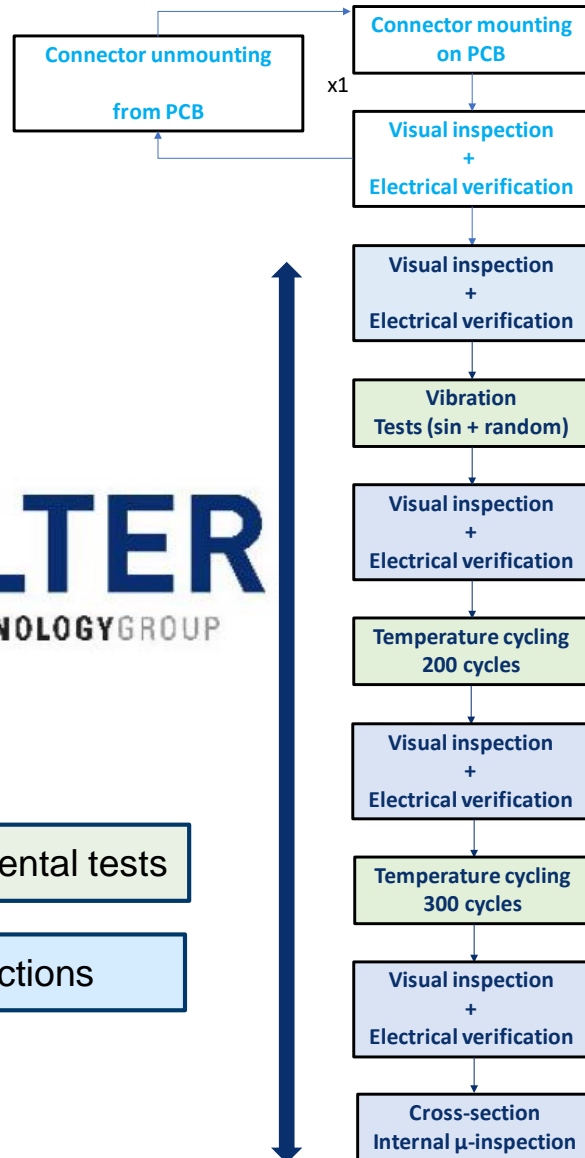
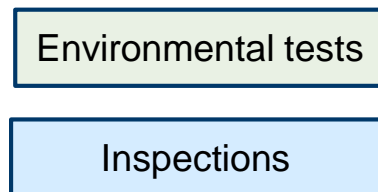
**No changes on the DUT natural frequencies are observed**





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Temperature  
cycling



# TEMPERATURE CYCLING: SET-UP AND CONDITIONS



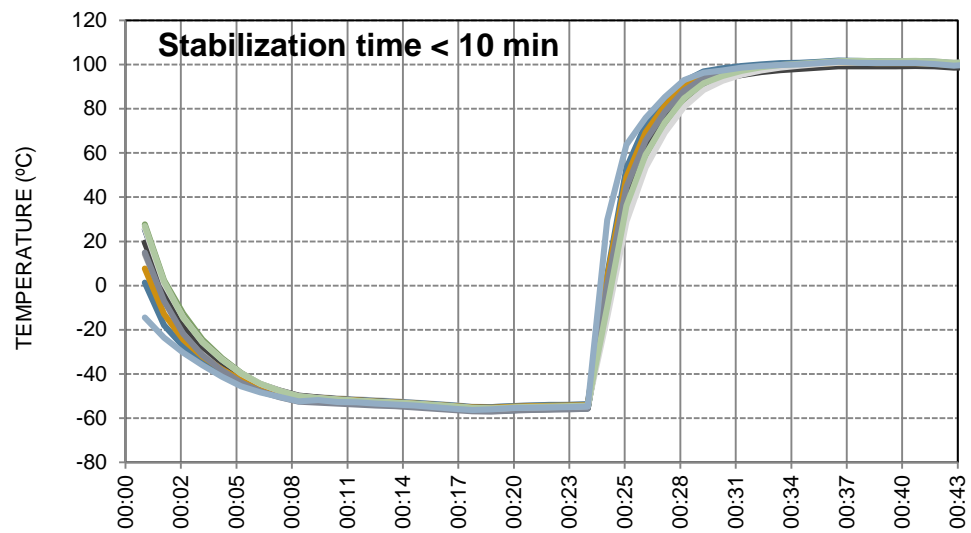
High temperature	100 °C
Low temperature	- 55 °C
Soak time	15 min

ESA speciation for soldered connections imposes temperature ramps  $< 10\text{ }^{\circ}\text{C}/\text{min}$

According to the customer specifications **harder conditions** were applied.



## Thermal shock between two air baths.



DUT  
Hot bath  
Cold bath

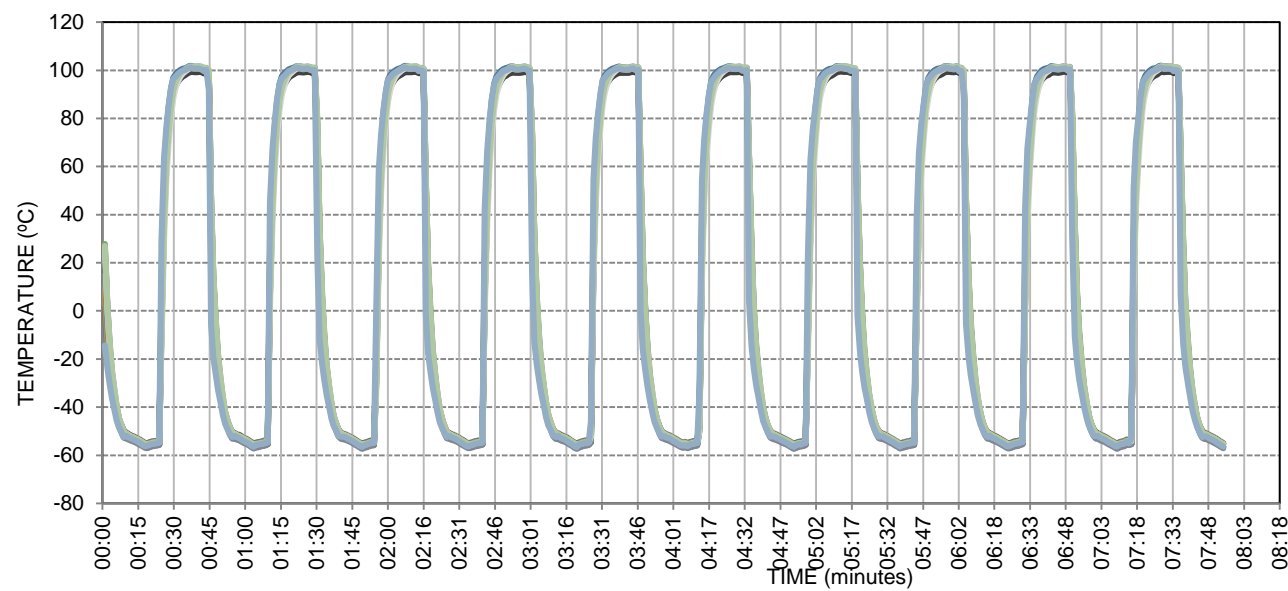




# TEMPERATURE CYCLING: SET-UP AND CONDITIONS



To ensure the test reliability the temperature is continually monitored with **ISO17025**-calibrated thermocouples attached to the DUT surface.



Temperature register of 10 representative cycles

PCB	ComboD S/N 0	ComboD S/N 1	ComboD S/N 2	Standard S/N 0	Standard S/N 1	Standard S/N 2	High S/N 0	High S/N 1	High S/N 2
Min	-57.0	-56.6	-56.7	-57.0	-57.0	-56.8	-57.0	-57.0	-57.0
Max	101.2	102.4	100.6	102.1	101.9	103.0	102.7	102.3	102.8

Max and min temperatures are within the tolerances stated by MIL-STD-202 TM107

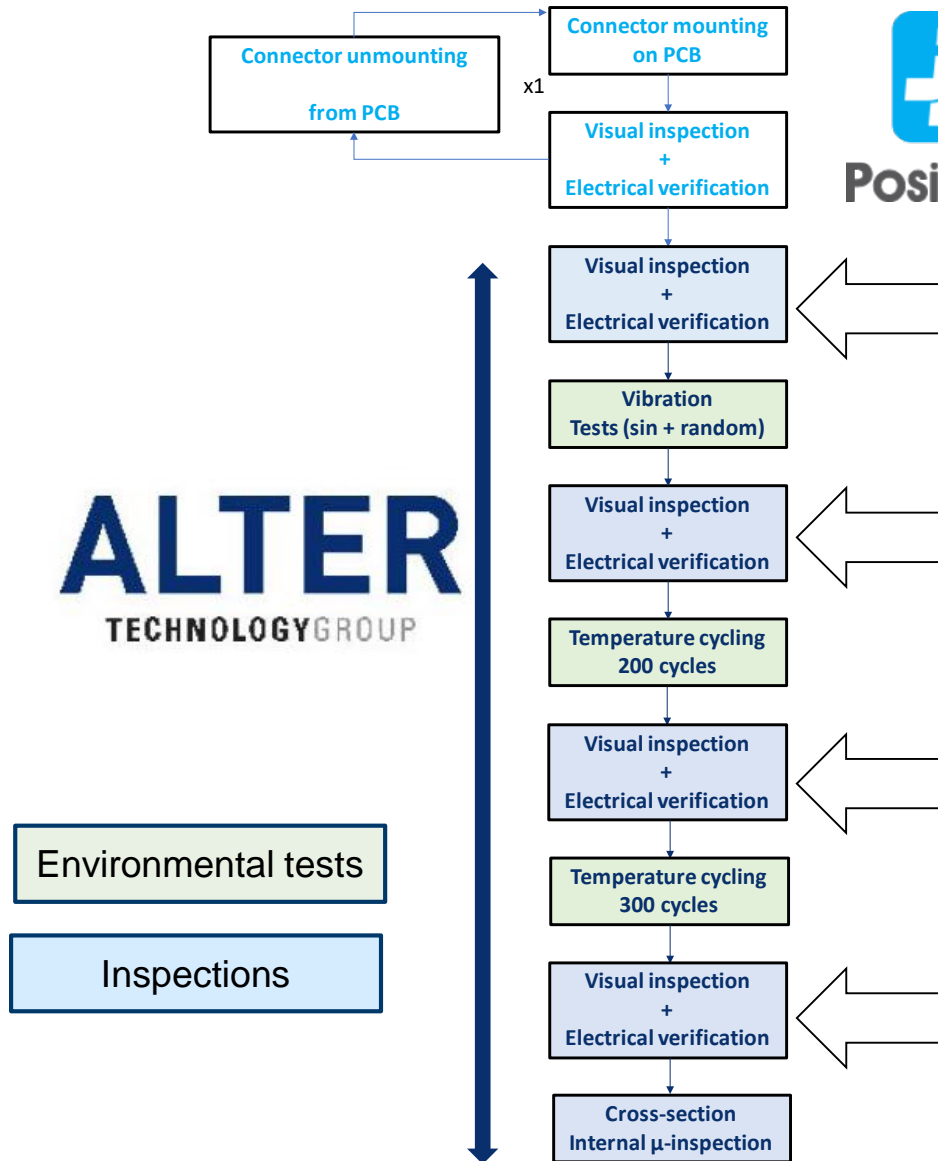




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# Visual inspection





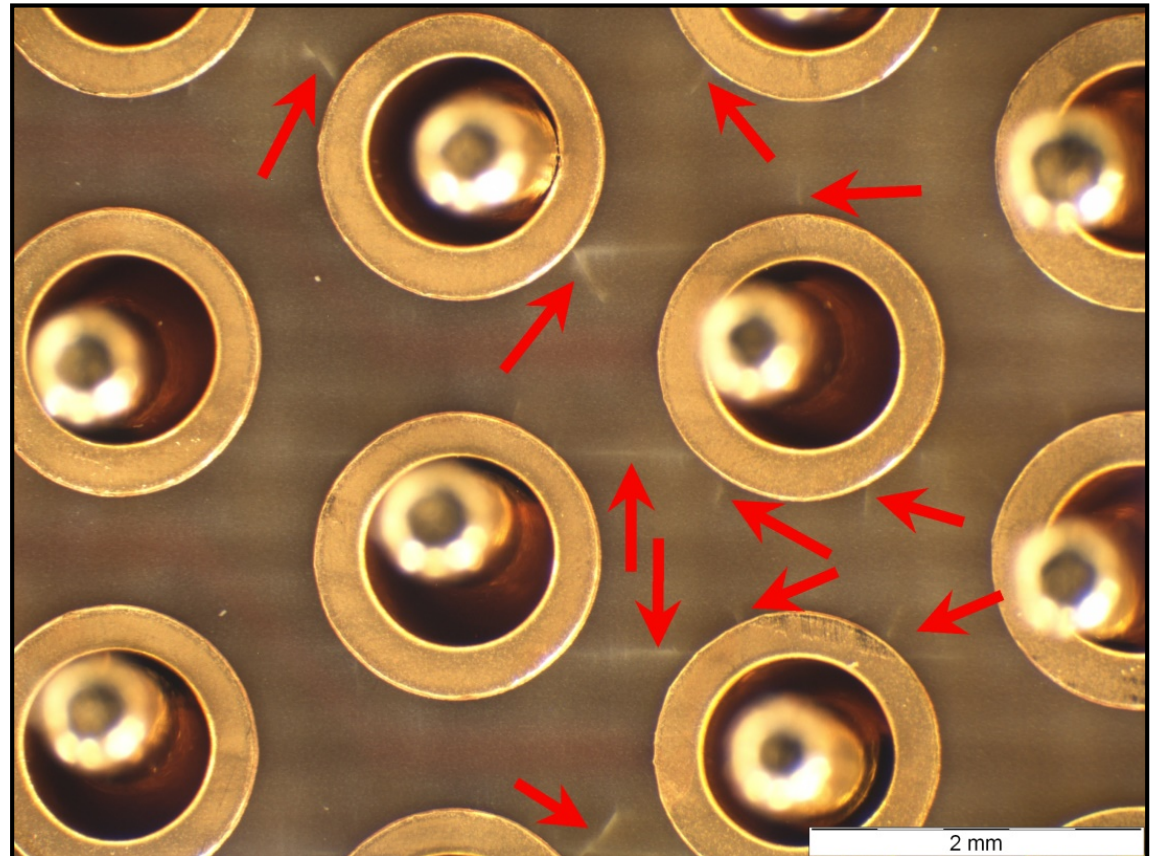
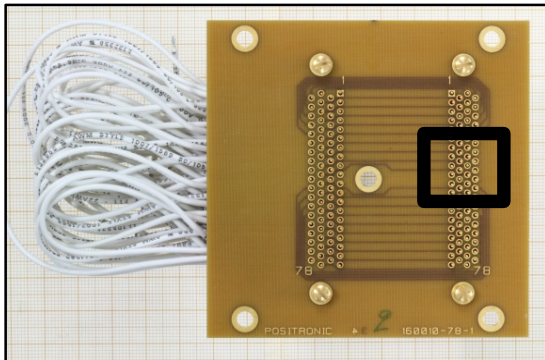
# VISUAL INSPECTION



For most of inspected connectors and PCB  
no noticeable deviations were observed

In one case small marks were  
observed near the PTH after  
mounting and unmounting test.

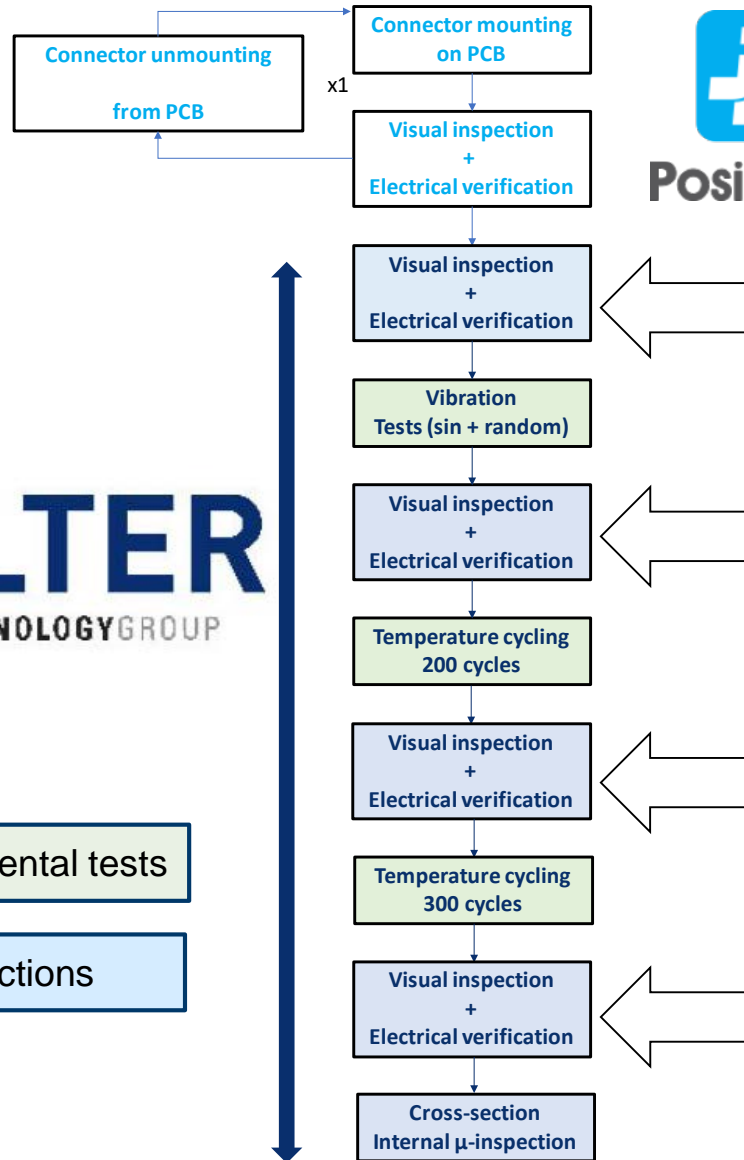
No evolution was observed  
after each environmental test



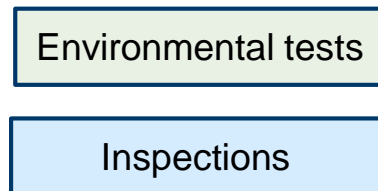




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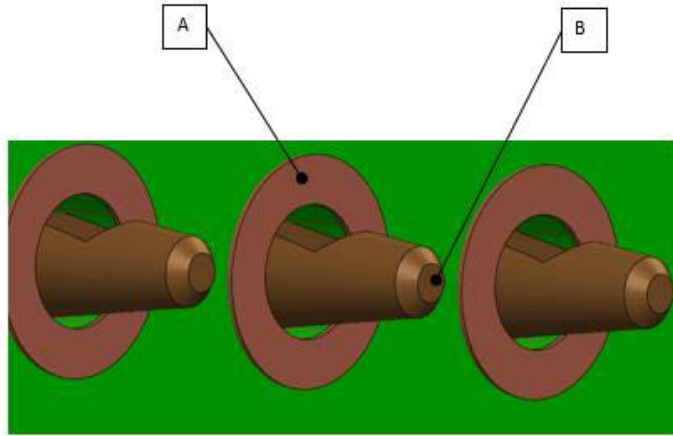
# Electrical verification



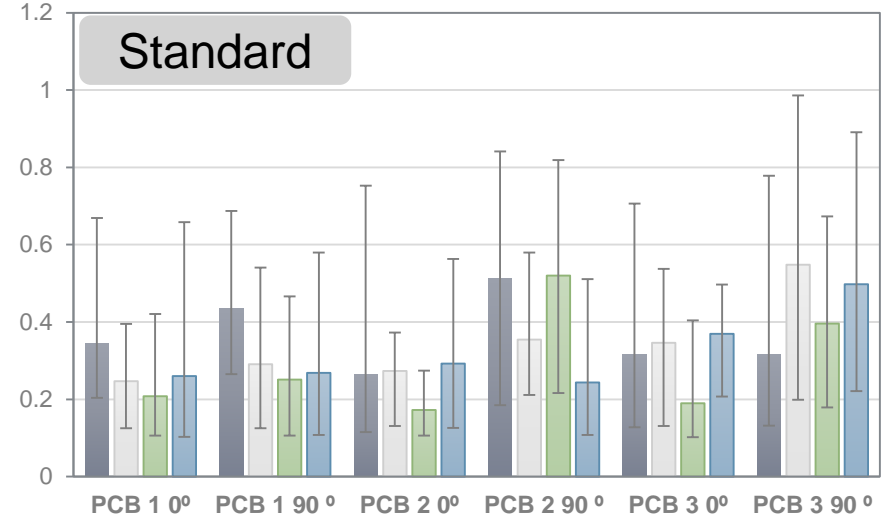
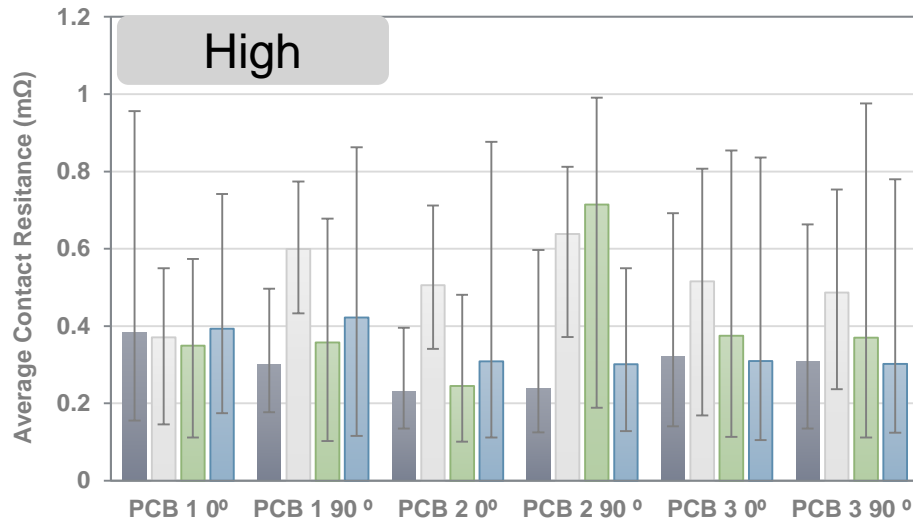
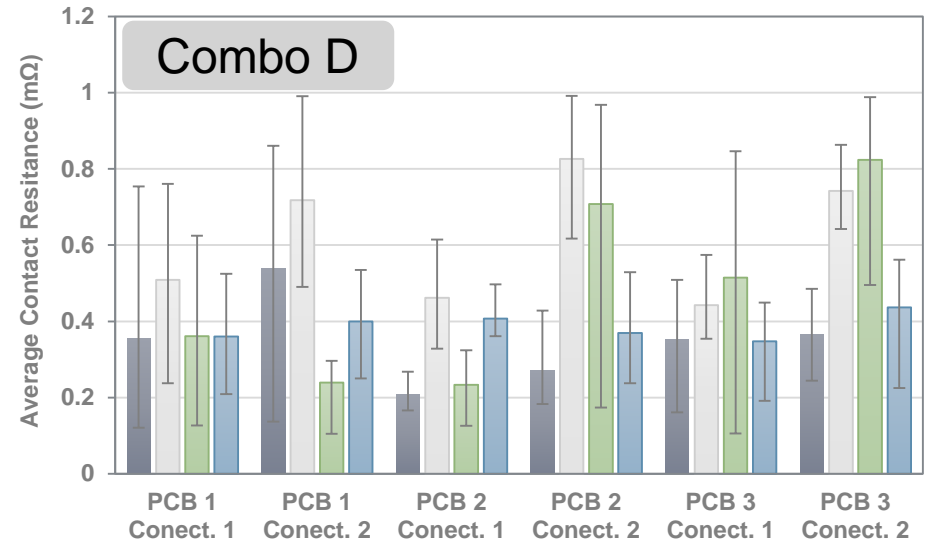


# VISUAL INSPECTION

In all the cases  $R < 1 \text{ m}\Omega$  no variations of statistical significance were observed



■ Initial ■ Vibration ■ 200 Temp Cycles ■ 300 Temp Cycles

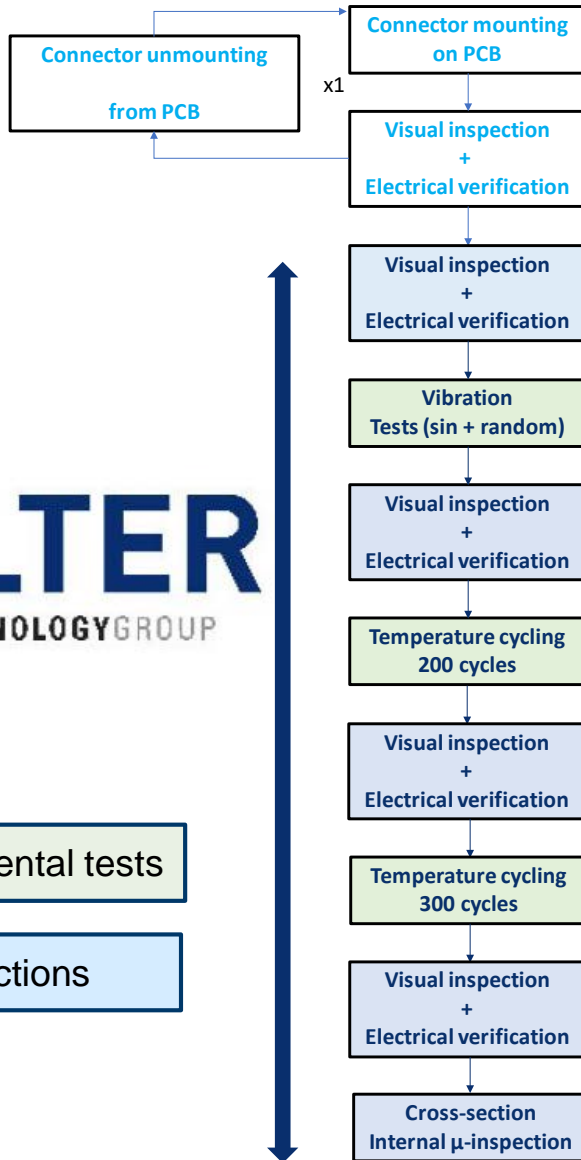






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Microsectioning



# MICROSECTIONING & MICROINSPECTION

Accurate wire cutting



Cold Mounting  
suitable for sensitive parts



Multi-step delicate  
gridding & polishing



μ-sectioning

- Selected parts are separated from PCB & cut using a precision diamond wire saw.
- Each sample placed in a mounting mold & embedded into epoxy resin (low exothermic).
- Luminescent marker added to the resin to analyse defects using its fluorescence.
- Automatic Grinding/polishing machine.
- Normal and/or fluorescent micro-inspection



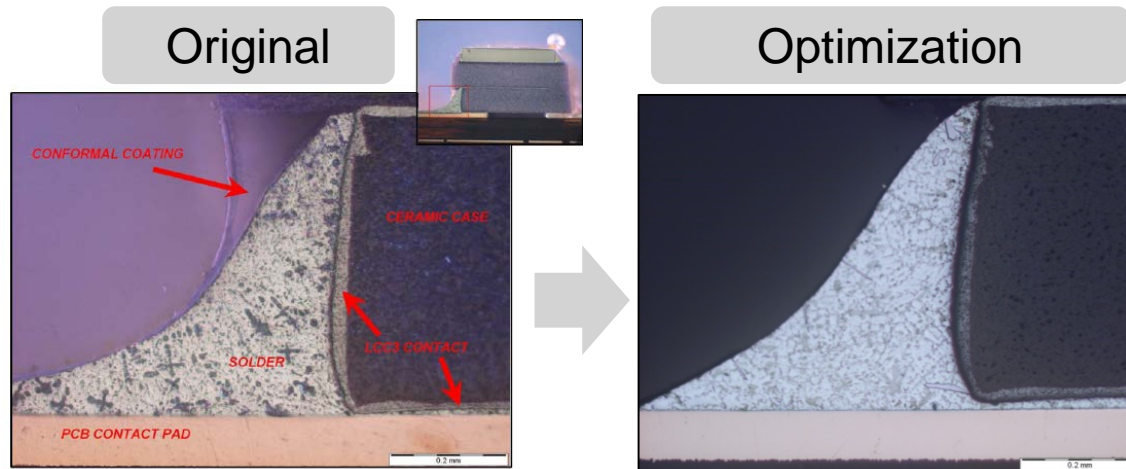
Visual & fluorescent  
μ-inspection



# Gridding and Polishing optimization by DOE methodology.



Results presented at the **Electronic Materials and Processes for Space**  
**9th Workshop, YVERDON-LES-BAINS**



- ✓ **Control the removal rate** depending on Pressure, Time & Rotational Speed.
- ✓ **Damages reduction** produced by the grinding process.

## Certifications

### Certified inspectors:

Inspection of crimping connections (ECSS-Q-ST-70-26)  
Inspection of solder joints for SM & mixed technology (ECSS-Q-ST-70-38).

### To be announced:

ESA Recommended company for PCB assembly verifications (ECSS-Q-ST-70-38).

### In progress:

ISO17025 certification to conduct PCB verification programmes (ECSS-Q-ST-70-38)



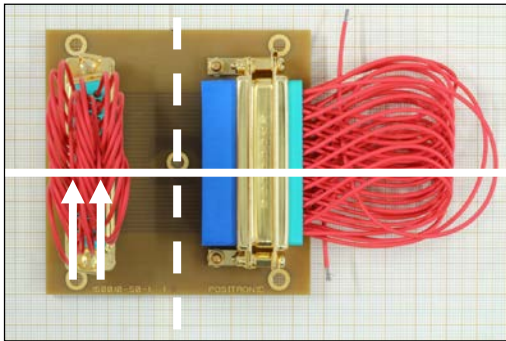


# MICROSECTIONING & MICROINSPECTION

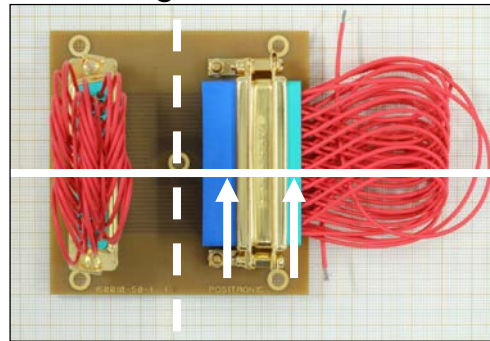
**Through and an detailed inspection in different inspection planes**

Standard and high density connectors

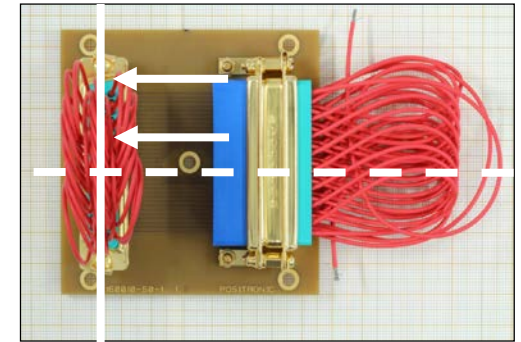
Transversal cut  
vertical connector



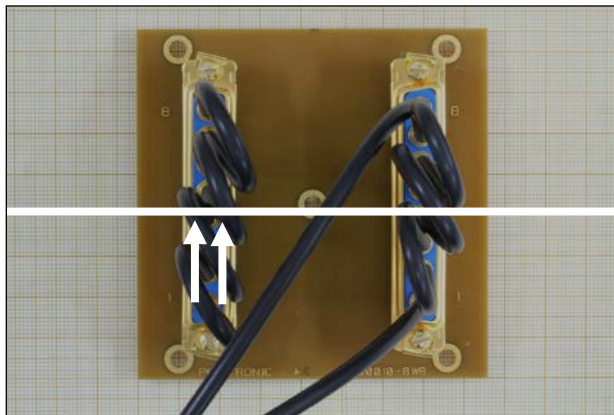
Transversal cut  
right connector



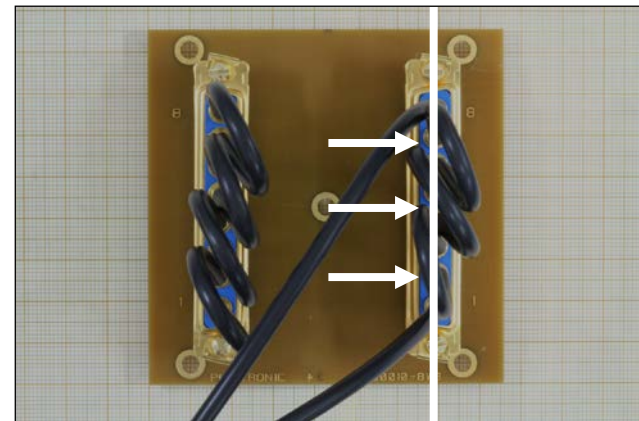
Longitudinal cut  
vertical connector



Transversal cut  
vertical connector



Longitudinal cut  
vertical connector

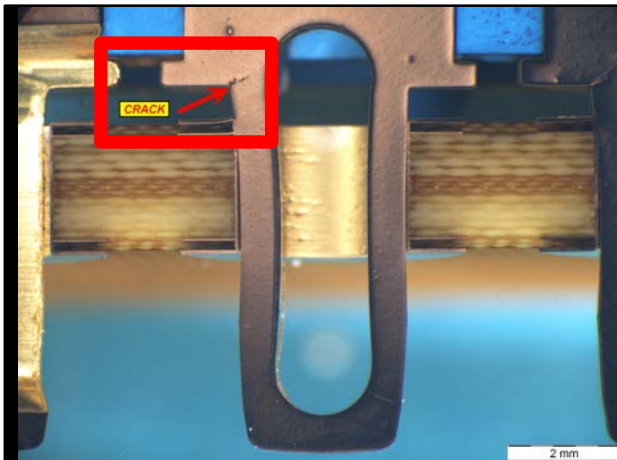


Combo-D  
connectors



# MICROSECTIONING & MICROINSPECTION

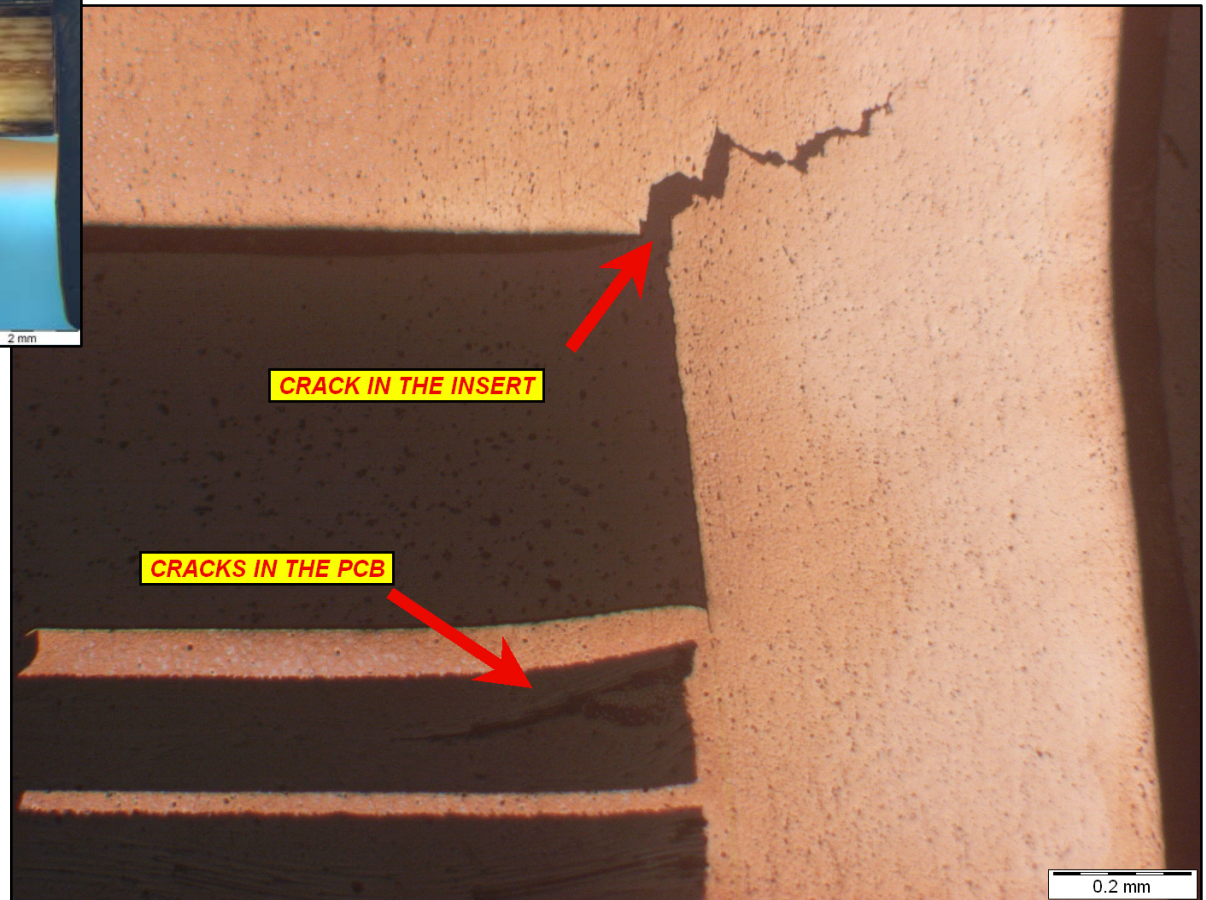
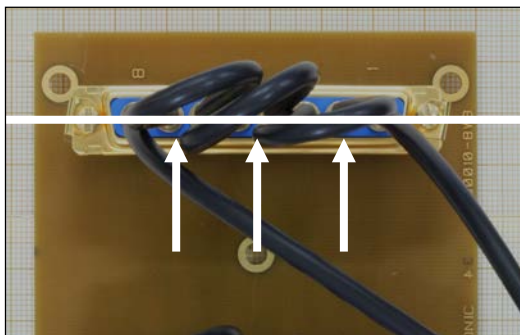
## Combo-D connectors



### Cracks:

- Base of the pin insert
- PCB resin

No other anomalies are observed

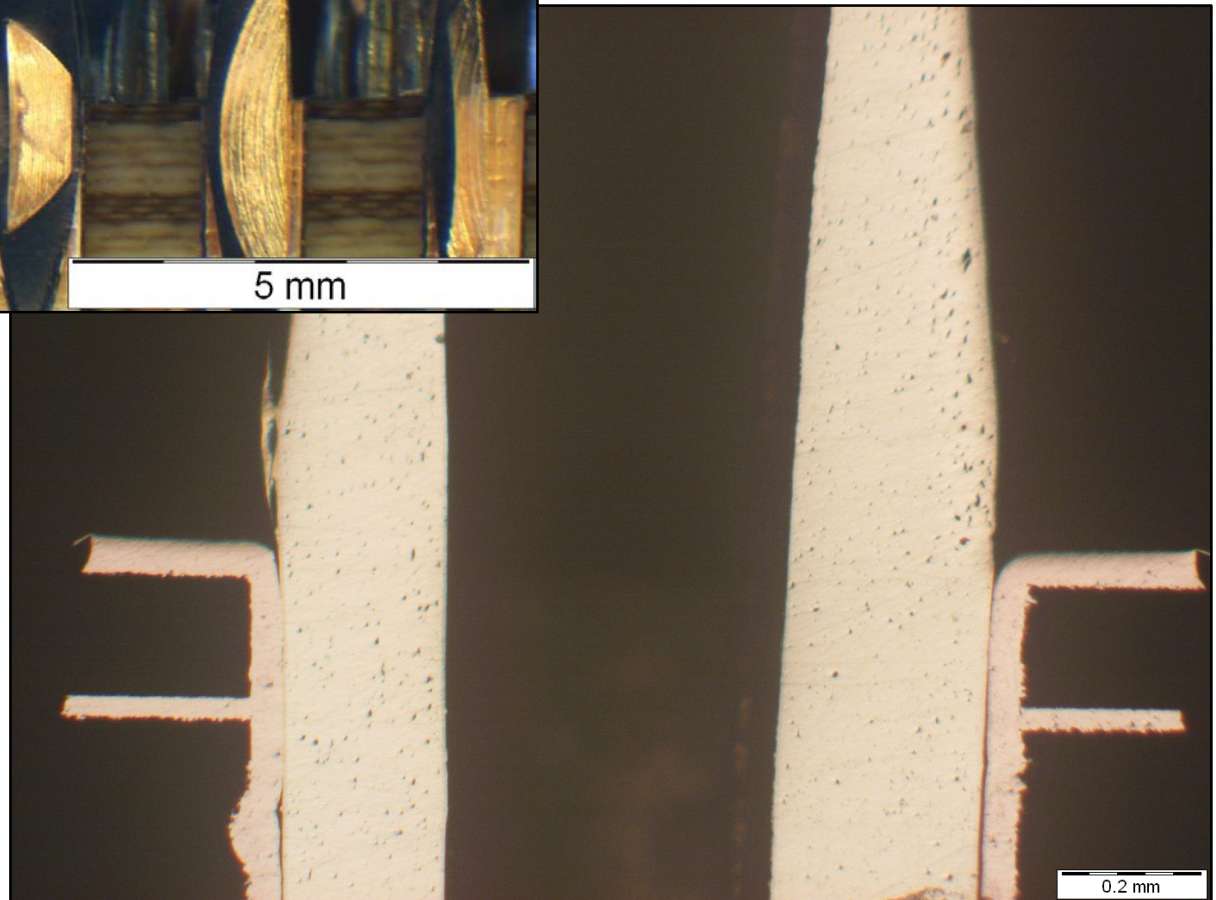
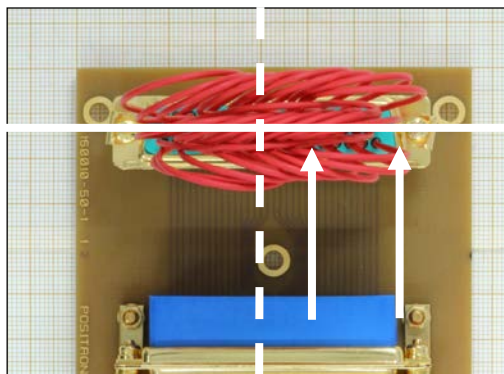
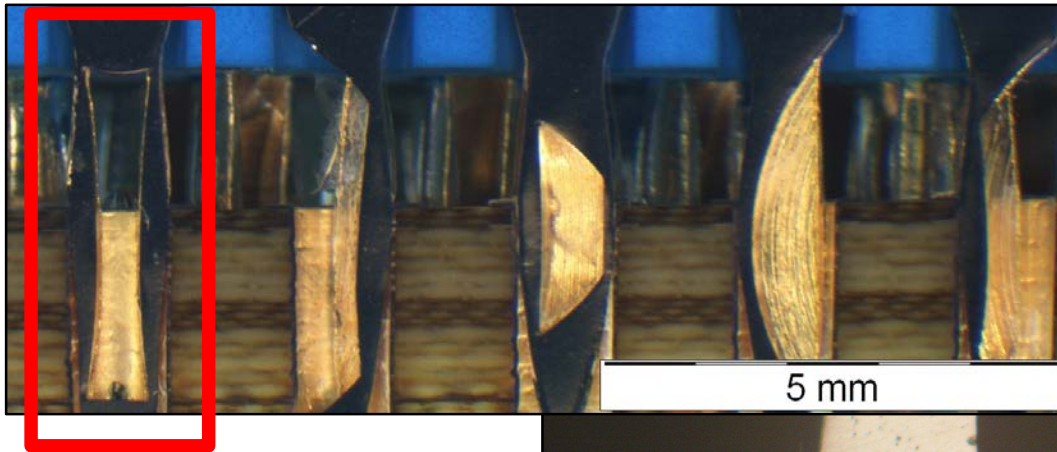




# MICROSECTIONING & MICROINSPECTION

Standard and high density connectors

No anomalies observed





# 1<sup>ST</sup> GENERATION SUMMARY



**Standard and high density connectors successfully pass all the tests**

Standard and  
high density



Size 22    Size 20

**Environmental**



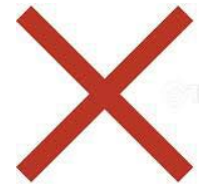
**Visual  
+  
Electrical**



**μ-inspection**



Combo-D



**Detailed μ-inspection enables Positronic to identify the trouble  
and develop new design to overcome the observed issues**

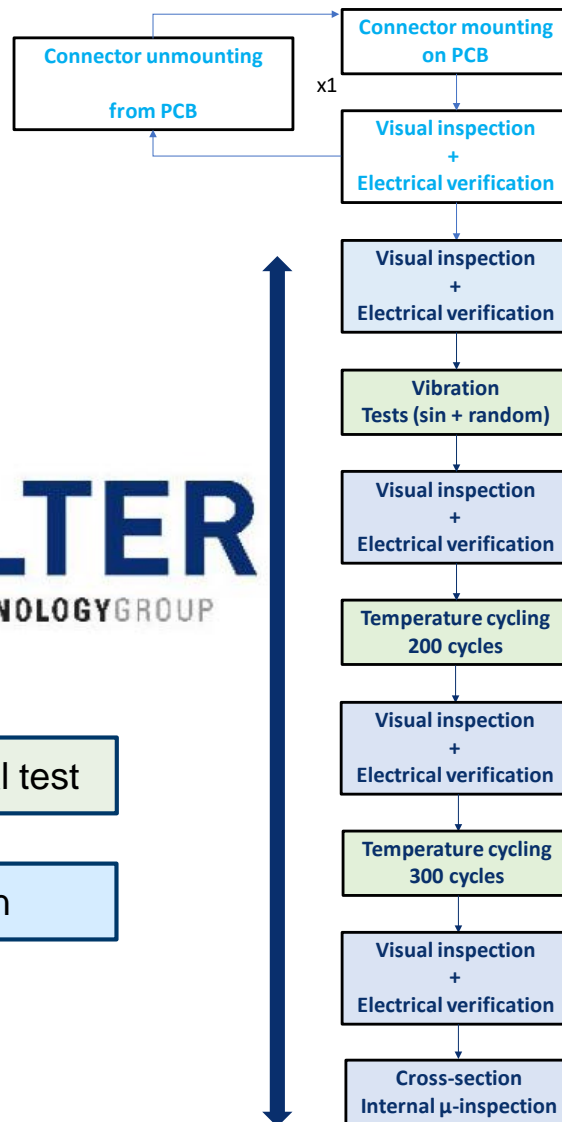




# 2<sup>ND</sup> GENERATION SUMMARY



Positronic®



In some cases initial external visual inspection revealed anomalies (crazing) at the PCB.

**Environmental test**  
All the inspected specimens successfully pass the environmental tests and the electrical verifications.

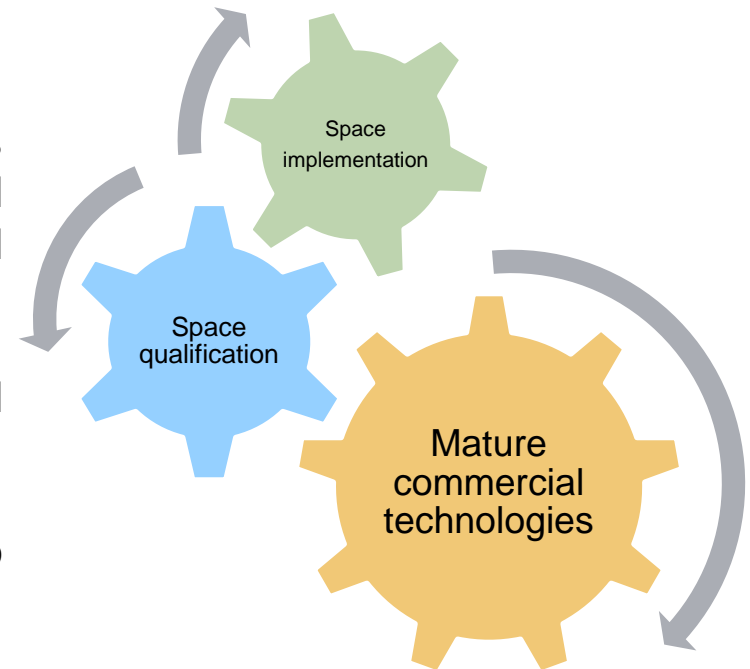
**Microsection inspection**  
Dissimilar results. Further developments in progress.



# SUMMARY.



- Different types of **press-fit connectors** conceived for different applications has been assessed for their implementation in **space environments**.
- The verification program included:
  - **Hard environmental** (vibration and temperature cycling) tests.
  - Control **electrical and visual inspections**.
  - Detailed **microsection** inspections.
- **Standard and high density** connectors **successfully passed** all the tests and inspections, demonstrating high reliability and assembly consistency.
- **Combo-D** presented **internal cracks** as revealed by  $\mu$ -inspection.
- **New Combo-D** are under development intending to overcome such shortcoming.







# THANK YOU FOR YOUR KIND ATTENTION!

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